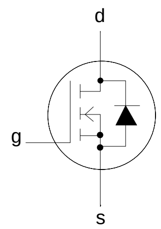
N-channel TrenchMOS™ transistor Logic level FET

PHB11N03LT, PHD11N03LT

FEATURES

- **'Trench'** technology
- Low on-state resistance
- Fast switching
- Logic level compatible

SYMBOL



QUICK REFERENCE DATA

V_{DSS} = 30 V

I_D = 10.5 A

$R_{DS(ON)} \leq$ 150 mΩ (V_{GS} = 5 V)

$R_{DS(ON)} \leq$ 130 mΩ (V_{GS} = 10 V)

GENERAL DESCRIPTION

N-channel enhancement mode, logic level, field-effect power transistor in a plastic envelope using '**trench**' technology.

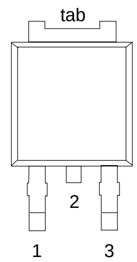
Applications:-
- d.c. to d.c. converters
- switched mode power supplies

The PHB11N03LT is supplied in the SOT404 (D^2PAK) surface mounting package.
The PHD11N03LT is supplied in the SOT428 (DPAK) surface mounting package.

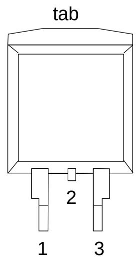
PINNING

PIN	DESCRIPTION
1	gate
2	drain [1]
3	source
tab	drain

SOT428 (DPAK)



SOT404 (D^2PAK)



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{DSS}	Drain-source voltage	T_j = 25 ˚C to 175˚C	-	30	V
V_{DGR}	Drain-gate voltage	T_j = 25 ˚C to 175˚C; R_{GS} = 20 kΩ	-	30	V
V_{GS}	Gate-source voltage		-	± 15	V
V_{GSM}	Pulsed gate-source voltage		-	± 20	V
I_D	Continuous drain current	T_{mb} = 25 ˚C	-	10.3	A
		T_{mb} = 100 ˚C	-	7.3	A
I_{DM}	Pulsed drain current	T_{mb} = 25 ˚C	-	41	A
P_D	Total power dissipation	T_{mb} = 25 ˚C	-	33	W
T_j, T_{stg}	Operating junction and storage temperature		- 55	175	˚C

1 It is not possible to make contact to pin 2 of the SOT404 or SOT428 package

AVALANCHE ENERGY LIMITING VALUES

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
E_{AS}	Non-repetitive avalanche energy	Unclamped inductive load, I_{AS} = 3.3 A; t_p = 220 µs; T_j prior to avalanche = 25˚C; V_{DD} ≤ 15 V; R_{GS} = 50 Ω; V_{GS} = 5 V; refer to fig:15	-	25	mJ
I_{AS}	Peak non-repetitive avalanche current		-	10.3	A

THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th\ j\text{-}mb}$	Thermal resistance junction to mounting base		-	4.5	K/W
$R_{th\ j\text{-}a}$	Thermal resistance junction to ambient	SOT428 and SOT404 package, pcb mounted, minimum footprint	50	-	K/W

ELECTRICAL CHARACTERISTICS

T_j= 25˚C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)DSS}$	Drain-source breakdown voltage	V_{GS} = 0 V; I_D = 0.25 mA;	30	-	-	V
		T_j = -55˚C	26	-	-	V
$V_{GS(TO)}$	Gate threshold voltage	V_{DS} = V_{GS}; I_D = 1 mA	1.0	1.5	2.0	V
		T_j = 175˚C	0.5	-	-	V
		T_j = -55˚C	-	-	2.3	V
$R_{DS(ON)}$	Drain-source on-state resistance	V_{GS} = 10 V; I_D = 5.5 A	-	100	130	mΩ
		V_{GS} = 5 V; I_D = 5.5 A	-	120	150	mΩ
		T_j = 175˚C	-	250	315	mΩ
g_{fs}	Forward transconductance	V_{DS} = 25 V; I_D = 5.5 A	4	7	-	S
I_{GSS}	Gate source leakage current	V_{GS} = ±5 V; V_{DS} = 0 V	-	10	100	nA
I_{DSS}	Zero gate voltage drain current	V_{DS} = 30 V; V_{GS} = 0 V;	-	0.05	10	µA
		T_j = 175˚C	-	-	500	µA
$Q_{g(tot)}$	Total gate charge	I_D = 10 A; V_{DD} = 15 V; V_{GS} = 5 V	-	3.8	-	nC
Q_{gs}	Gate-source charge		-	1.2	-	nC
Q_{gd}	Gate-drain (Miller) charge		-	1.7	-	nC
$t_{d\ on}$	Turn-on delay time	V_{DD} = 30 V; R_D = 2.7 Ω;	-	6	16	ns
t_r	Turn-on rise time	R_G = 10 Ω; V_{GS} = 5 V	-	64	80	ns
$t_{d\ off}$	Turn-off delay time	Resistive load	-	20	30	ns
t_f	Turn-off fall time		-	26	40	ns
L_d	Internal drain inductance	Measured from tab to centre of die	-	3.5	-	nH
L_d	Internal drain inductance	Measured from drain lead to centre of die (SOT78 package only)	-	4.5	-	nH
L_s	Internal source inductance	Measured from source lead to source bond pad	-	7.5	-	nH
C_{iss}	Input capacitance	V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz	-	250	330	pF
C_{oss}	Output capacitance		-	55	75	pF
C_{rss}	Feedback capacitance		-	42	55	pF

REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS

T_j = 25˚C unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_S	Continuous source current (body diode)		-	-	10.3	A
I_{SM}	Pulsed source current (body diode)		-	-	41	A
V_{SD}	Diode forward voltage	I_F = 10 A; V_{GS} = 0 V	-	1.15	1.5	V
t_{rr}	Reverse recovery time	I_F = 10 A; -dI_F/dt = 100 A/µs;	-	35	-	ns
Q_{rr}	Reverse recovery charge	V_{GS} = 0 V; V_R = 30 V	-	55	-	nC

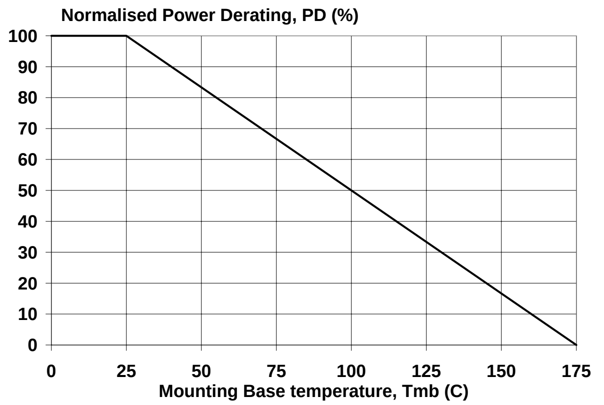


Fig.1. Normalised power dissipation.
$PD\% = 100 \cdot P_D/P_{D\ 25\ ^\circ C} = f(T_{mb})$

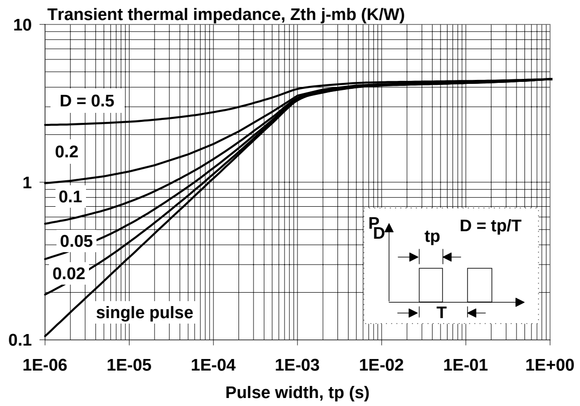


Fig.4. Transient thermal impedance.
$Z_{th\ j\text{-}mb} = f(t)$; parameter $D = t_p/T$

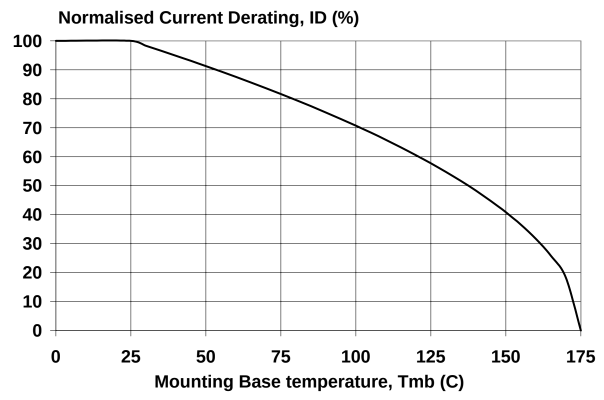


Fig.2. Normalised continuous drain current.
$ID\% = 100 \cdot I_D/I_{D\ 25\ ^\circ C} = f(T_{mb})$; conditions: $V_{GS} \geq 5$ V

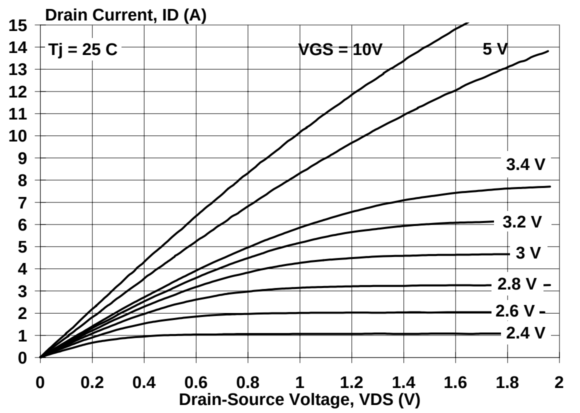


Fig.5. Typical output characteristics, $T_j = 25\ ^\circ C$.
$I_D = f(V_{DS})$

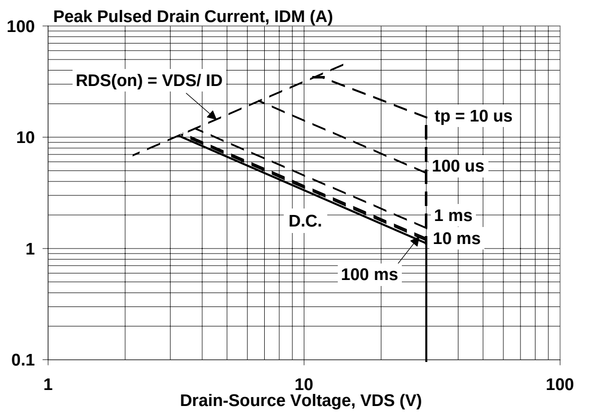


Fig.3. Safe operating area. $T_{mb} = 25\ ^\circ C$
I_D & $I_{DM} = f(V_{DS})$; I_{DM} single pulse; parameter t_p

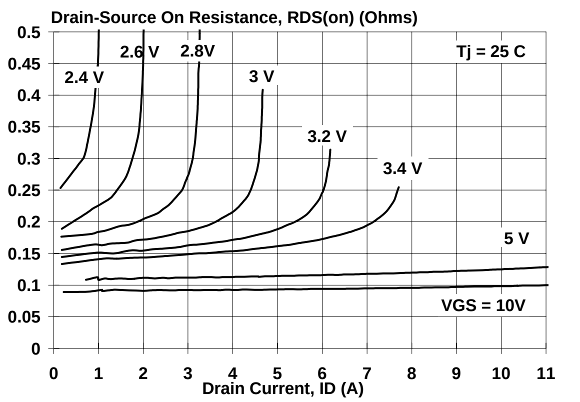


Fig.6. Typical on-state resistance, $T_j = 25\ ^\circ C$.
$R_{DS(ON)} = f(I_D)$

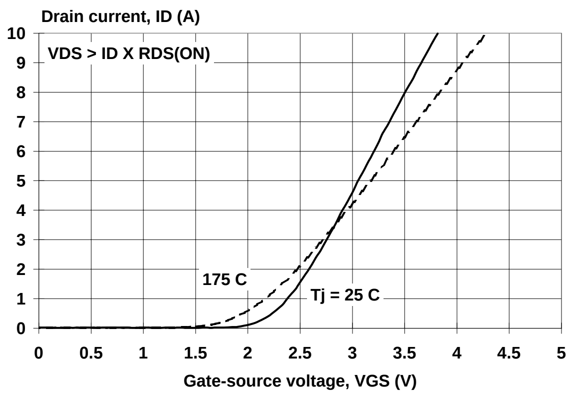


Fig.7. Typical transfer characteristics.
$I_D = f(V_{GS})$

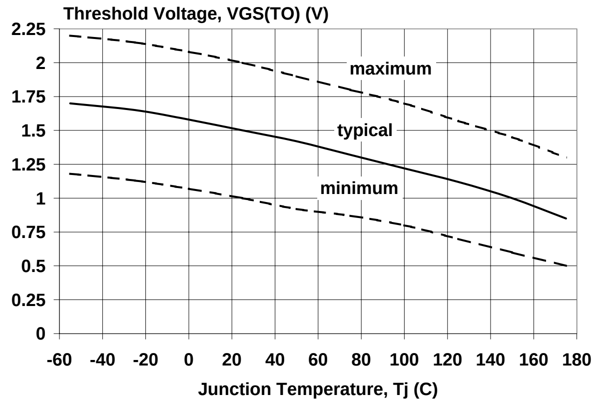


Fig.10. Gate threshold voltage.
$V_{GS(TO)} = f(T_j)$; conditions: I_D = 1 mA; $V_{DS} = V_{GS}$

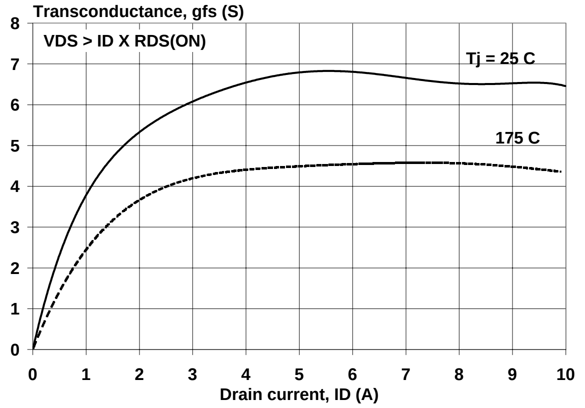


Fig.8. Typical transconductance, T_j = 25 ˚C.
$g_{fs} = f(I_D)$

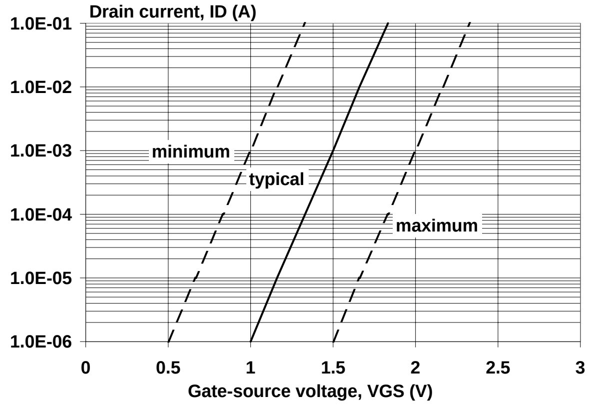


Fig.11. Sub-threshold drain current.
$I_D = f(V_{GS)}$; conditions: T_j = 25 ˚C; $V_{DS} = V_{GS}$

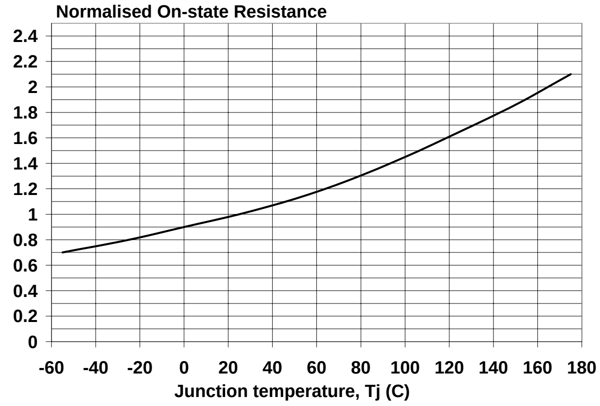


Fig.9. Normalised drain-source on-state resistance.
$R_{DS(ON)}/R_{DS(ON)25\,˚C} = f(T_j)$

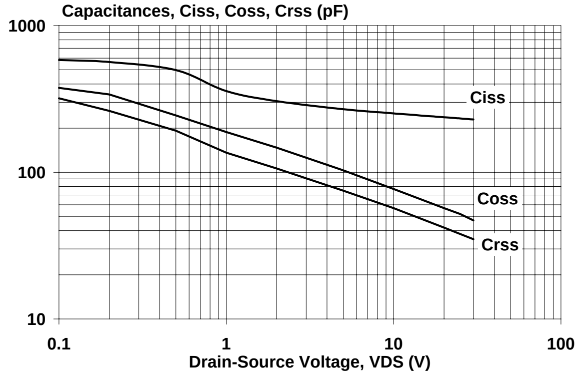


Fig.12. Typical capacitances, C_{iss}, C_{oss}, C_{rss}.
$C = f(V_{DS})$; conditions: V_{GS} = 0 V; f = 1 MHz

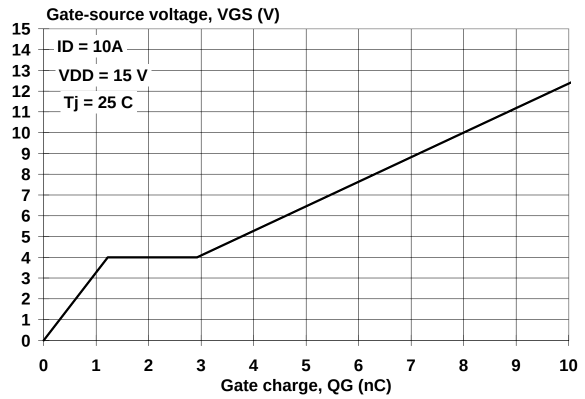


Fig.13. Typical turn-on gate-charge characteristics. $V_{GS} = f(Q_G)$

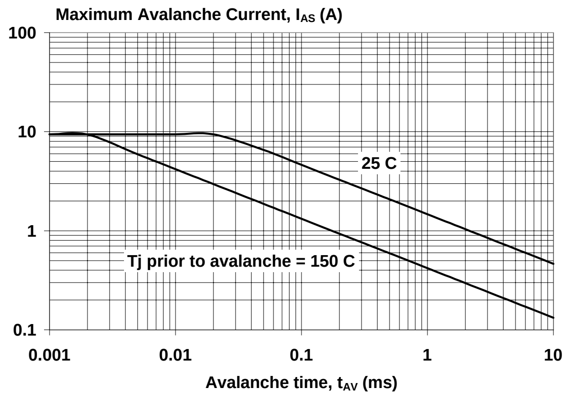


Fig.15. Maximum permissible non-repetitive avalanche current (I_{AS}) versus avalanche time (t_{AV}); unclamped inductive load

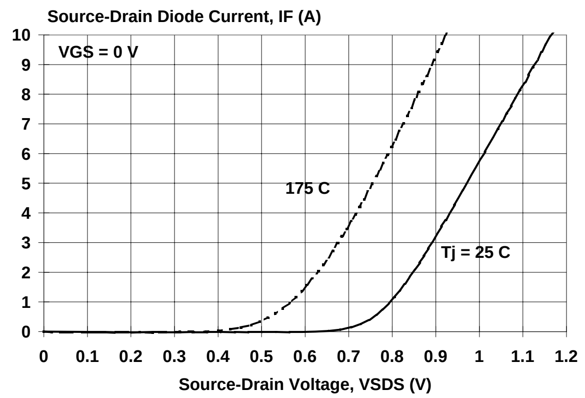
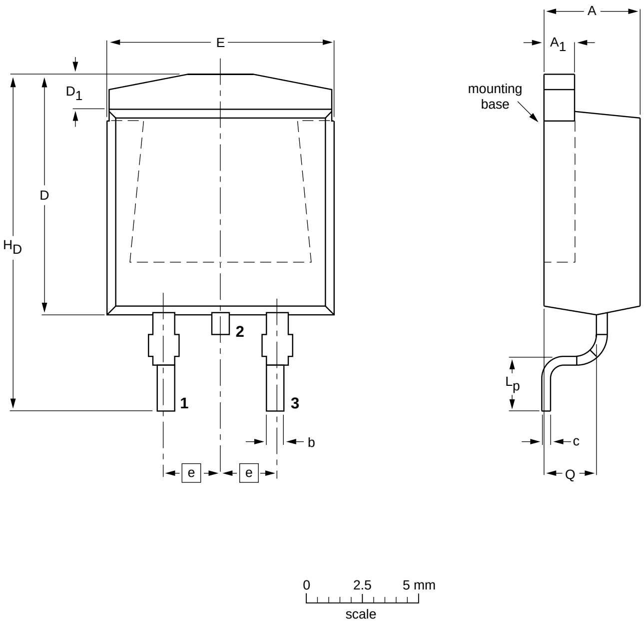


Fig.14. Typical reverse diode current. $I_F = f(V_{SDS})$; conditions: $V_{GS} = 0$ V; parameter T_j

MECHANICAL DATA

Plastic single-ended surface mounted package (Philips version of D^2-PAK); 3 leads (one lead cropped) **SOT404**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	c	D max.	D_1	E	e	L_p	H_D	Q
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	2.54	2.90 2.10	15.40 14.80	2.60 2.20

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT404						98-12-14 99-06-25

Fig.16. SOT404 surface mounting package. Centre pin connected to mounting base.

Notes

1. This product is supplied in anti-static packaging. The gate-source input must be protected against static discharge during transport or handling.
2. Refer to SMD Footprint Design and Soldering Guidelines, Data Handbook SC18.
3. Epoxy meets UL94 V0 at 1/8".

MOUNTING INSTRUCTIONS

Dimensions in mm

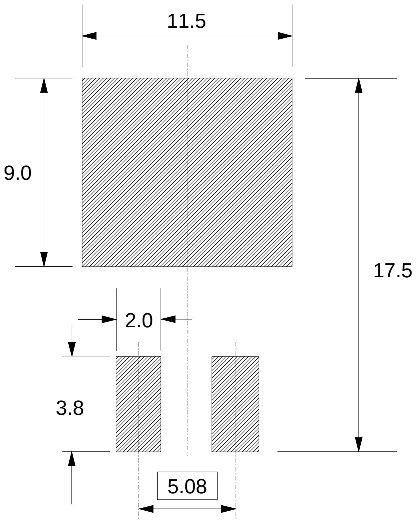
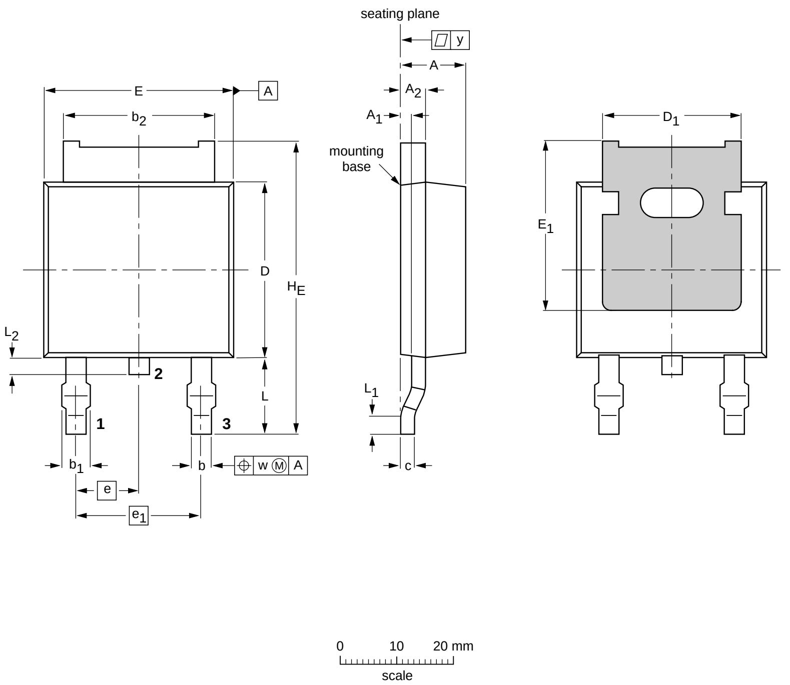


Fig.17. SOT404 : soldering pattern for surface mounting.

MECHANICAL DATA

Plastic single-ended surface mounted package (Philips version of D-PAK); 3 leads (one lead cropped) **SOT428**



DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A_1(1)	A_2	b	b_1 max.	b_2	c	D max.	D_1 max.	E max.	E_1 min.	e	e_1	H_E max.	L	L_1 min.	L_2	w	y max.
mm	2.38 2.22	0.65 0.45	0.89 0.71	0.89 0.71	1.1 0.9	5.36 5.26	0.4 0.2	6.22 5.98	4.81 4.45	6.73 6.47	4.0	2.285	4.57	10.4 9.6	2.95 2.55	0.5	0.7 0.5	0.2	0.2

Note
1. Measured from heatsink back to lead.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT428						98-04-07

Fig.18. SOT428 surface mounting package. Centre pin connected to mounting base.

Notes
1. This product is supplied in anti-static packaging. The gate-source input must be protected against static discharge during transport or handling.
2. Refer to SMD Footprint Design and Soldering Guidelines, Data Handbook SC18.
3. Epoxy meets UL94 V0 at 1/8".

MOUNTING INSTRUCTIONS

Dimensions in mm

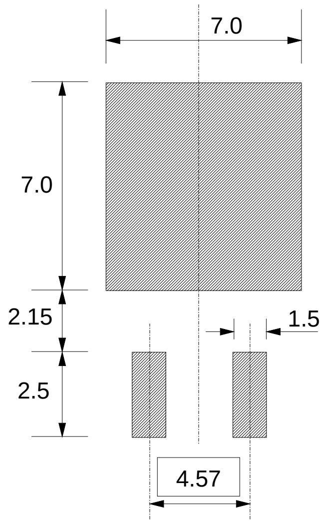


Fig.19. SOT428 : soldering pattern for surface mounting.

DEFINITIONS

Data sheet status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

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